Notice of References Cited Application/Control No. 10/696,233 Examiner Kyung H. Shin Applicant(s)/Patent Under Reexamination LI, HUIMIN Page 1 of 1

U.S. PATENT DOCUMENTS

*	į.	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0111996 A1	08-2002	Jones et al.	709/203
*	В	US-2002/0152305 A1	10-2002	Jackson et al.	709/224
*	С	US-2003/0055953 A1	03-2003	Motoyama et al.	709/224
*	D	US-2004/0088141 A1	05-2004	Ashley, Mark	702/184
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-		·	
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				•	
	0			•		
	Р					
	Q				<u> </u>	
	R				<u> </u>	
	s	,				
	Т				·	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	>						
	w						
	x	•					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.